

MiniSKiiP[®] 3 Dual

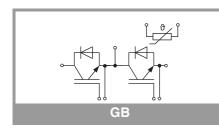
SKiiP39GB12VV1

Features

- Robust and soft freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognised file no. E63532

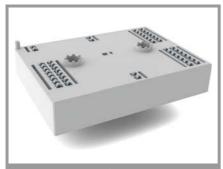
Remarks

- V_{CEsat}, V_F= chip level value
- Case temp. limited to $T_C=125^{\circ}C$ max. (for baseplateless modules $T_C=T_S$) • Product reliability results valid for
- Product reliability results valid for T_j≤150°C (recomm. Top = -40 ... +150°C)



| Symbol | Conditions | | Values | | | |
|------------------------|---|-------------------------|--------|---------|------|------|
| Inverter - | IGBT | | | | | |
| V _{CES} | T _i = 25 °C | | | 1200 | | V |
| lc | λ _{paste} =0.8 W/(mK) | T _s = 25 °C | | 379 | | Α |
| | T _j = 175 °C | T _s = 70 °C | | 302 | | Α |
| I _C | λ _{paste} =2.5 W/(mK) | T _s = 25 °C | | 575 | | Α |
| $T_j = 175 \text{ °C}$ | T _j = 175 °C | T _s = 70 °C | | 465 | | Α |
| I _{Cnom} | | | | 400 | | Α |
| I _{CRM} | I _{CRM} = 3 x I _{Cnom} | | | 1200 | | |
| V _{GES} | | | | -20 20 | | V |
| t _{psc} | $V_{CC} = 720 V$ $V_{GE} \le 15 V$ $V_{CES} \le 1200 V$ | T _j = 125 °C | | 10 | | μs |
| Tj | | | | -40 175 | | °C |
| Inverse - | Diode | | • | | | |
| l _F | λ _{paste} =0.8 W/(mK) | T _s = 25 °C | | 363 | | Α |
| | T _j = 175 °C | T _s = 70 °C | | 287 | | Α |
| I _F | λ _{paste} =2.5 W/(mK) | T _s = 25 °C | | 422 | | Α |
| | T _j = 175 °C | T _s = 70 °C | | 335 | | Α |
| I _{Fnom} | | | | 400 | | Α |
| I _{FRM} | $I_{FRM} = 2 \times I_{Fnom}$ | | | 800 | | Α |
| I _{FSM} | 10 ms, sin 180°, T _j = 150 °C | | | 1980 | | |
| Tj | | | | -40 175 | | |
| Module | | | | | | |
| I _{t(RMS)} | T _{terminal} = 80 °C, 20 A per spring | | | 280 | | |
| T _{stg} | | | | -40 125 | | |
| V _{isol} | AC sinus 50 Hz, t = 1 min | | | 2500 | | |
| Characte | eristics | | | | | |
| Symbol | Conditions | | min. | typ. | max. | Unit |
| Inverter - | IGBT | _ | min. | typ. | max. | |
| | $I_{0} = 400 \text{ A}$ | | 1 | 1 75 | 0.00 | 11 |

| Inverter | - IGBT | | | | | |
|----------------------|--|------------------------------|-----|-------|------|-----|
| V _{CE(sat)} | $I_{\rm C} = 400 {\rm A}$ | T _j = 25 °C | | 1.75 | 2.20 | V |
| | V _{GE} = 15 V chiplevel | T _j = 150 °C | | 2.20 | 2.50 | V |
| V _{CE0} | chiplevel | T _j = 25 °C | | 0.94 | 1.04 | V |
| | | T _j = 150 °C | | 0.88 | 0.98 | V |
| r _{CE} | V _{GE} = 15 V | T _j = 25 °C | | 2.0 | 2.9 | mΩ |
| | chiplevel | T _j = 150 °C | | 3.3 | 3.8 | mΩ |
| V _{GE(th)} | $V_{GE} = V_{CE}, I_{C} = 16 \text{ n}$ | nA | 5.5 | 6 | 6.5 | V |
| I _{CES} | $V_{GE} = 0 V, V_{CE} = 12$ | 00 V, T _j = 25 °C | | 0.1 | 0.3 | mA |
| Cies | N 05.14 | f = 1 MHz | | 24.04 | | nF |
| Coes | V _{CE} = 25 V V _{GE} = 0 V | f = 1 MHz | | 2.36 | | nF |
| C _{res} | | f = 1 MHz | | 2.36 | | nF |
| Q_{G} | - 8 V+ 15 V | • | | 4400 | | nC |
| R _{Gint} | | | | 1.9 | | Ω |
| t _{d(on)} | V _{CC} = 600 V | | | 410 | | ns |
| t _r | $I_{\rm C} = 400 {\rm A}$ | | | 68 | | ns |
| Eon | $R_{G \text{ on}} = 1.8 \Omega$ $R_{G \text{ off}} = 1.8 \Omega$ | | | 17.8 | | mJ |
| t _{d(off)} | di/dt _{on} = 7451 A/µs | | | 667 | | ns |
| t _f | di/dt _{off} = 3870 A/µs | | | 107 | | ns |
| E _{off} | V _{GE} = +15/-15 V | | | 47.5 | | mJ |
| R _{th(j-s)} | per IGBT, λ _{paste} =0.8 | 3 W/(mK) | | 0.16 | | K/W |
| R _{th(j-s)} | per IGBT, $\lambda_{\text{paste}}=2.5$ | 5 W/(mK) | | 0.08 | | K/W |



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SKiiP39GB12VV1

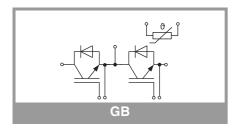
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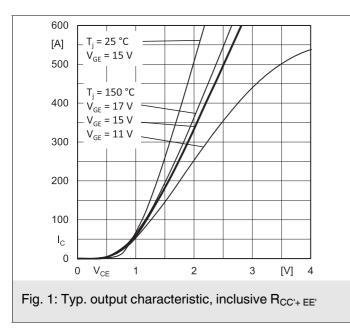
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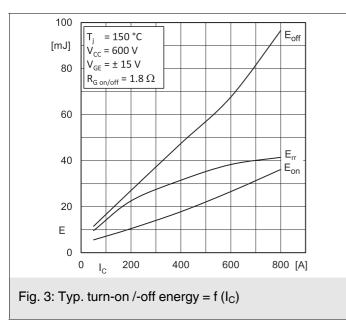
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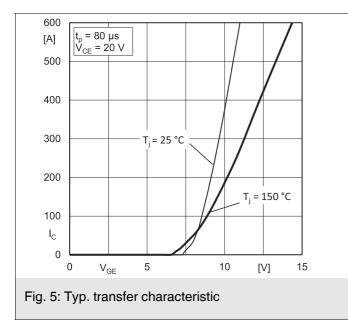
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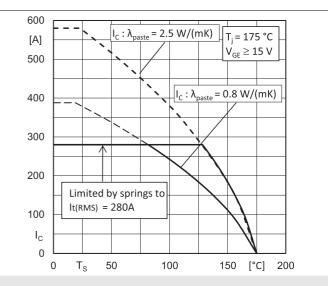
| Characte | ristics | | | | | |
|------------------------------------|--|-------------------------|----------|------|------|------|
| Symbol | Conditions | | min. | typ. | max. | Unit |
| Inverse - | | | | | | |
| $V_F = V_{EC}$ | I _F = 400 A | T _j = 25 °C | | 2.20 | 2.52 | V |
| V _{GE} = 0 V chiplevel | | T _j = 150 °C | | 2.15 | 2.47 | V |
| V _{F0} cl | chiplevel | T _j = 25 °C | | 1.30 | 1.50 | V |
| | | T _j = 150 °C | | 0.90 | 1.10 | V |
| r _F | chiplevel | T _j = 25 °C | | 2.3 | 2.6 | mΩ |
| | | T _j = 150 °C | | 3.1 | 3.4 | mΩ |
| I _{RRM} | I _F = 400 A | | | 427 | | Α |
| Q _{rr} | $di/dt_{off} = 7310 \text{ A/}\mu\text{s}$ | | | 62.5 | | μC |
| E _{rr} | V _{GE} = -15 V V _{CC} = 600 V | | | 31.5 | | mJ |
| R _{th(j-s)} | per Diode, λ_{paste} =0.8 W/(mK) | | | 0.19 | | K/W |
| R _{th(j-s)} | per Diode, λ_{paste} =2.5 W/(mK) | | | 0.15 | | K/W |
| Module | | | | | | |
| L _{CE} | | | | 15 | | nH |
| Ms | to heat sink | | 2 | | 2.5 | Nm |
| w | | | | 76 | | g |
| Temperat | ure Sensor | | | | | • |
| R ₁₀₀ | T _c =100°C (R ₂₅ =5 kΩ) | | 493 ± 5% | | | Ω |
| B _{25/85} | R _(T) =R ₂₅ *exp[B _{25/85} *(1/T-1/298)], [T]=K | | | 3420 | | К |

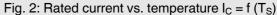


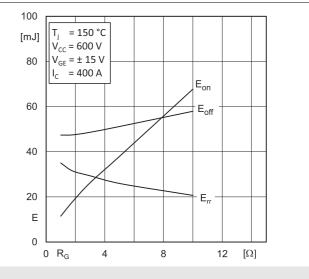


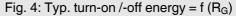


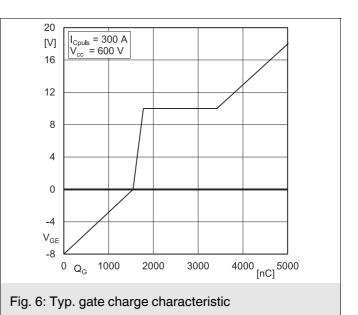




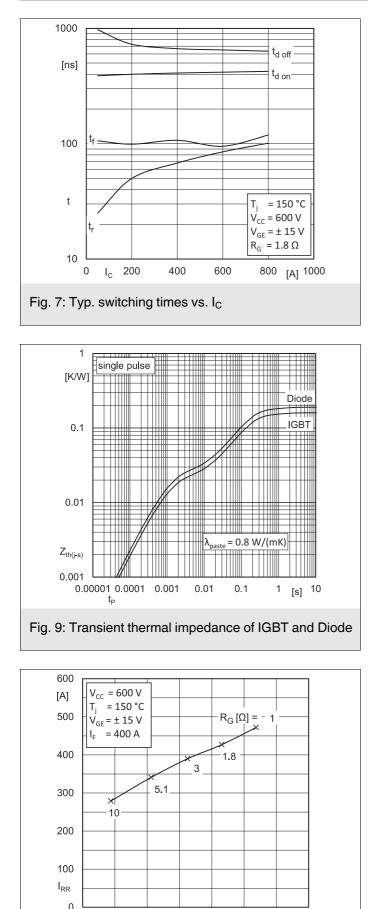


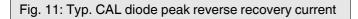












7000

3000 _{di_F/dt} 5000

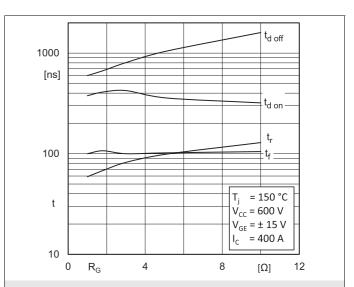
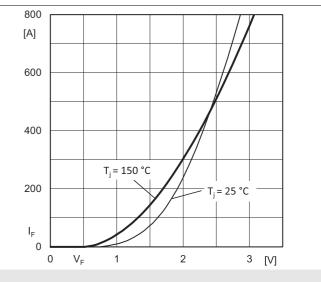
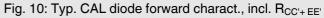
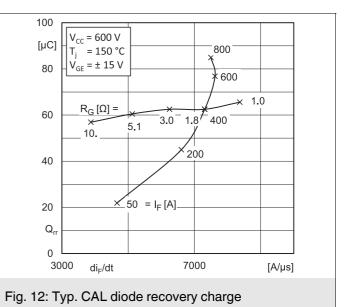


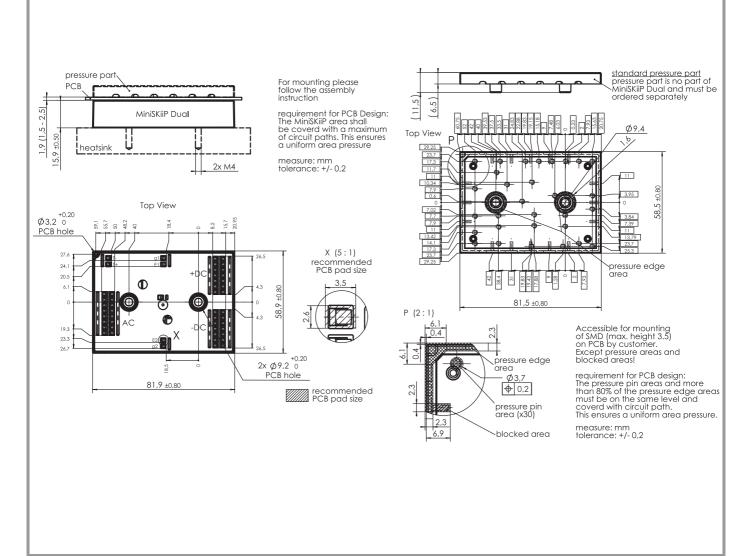
Fig. 8: Typ. switching times vs. gate resistor R_G



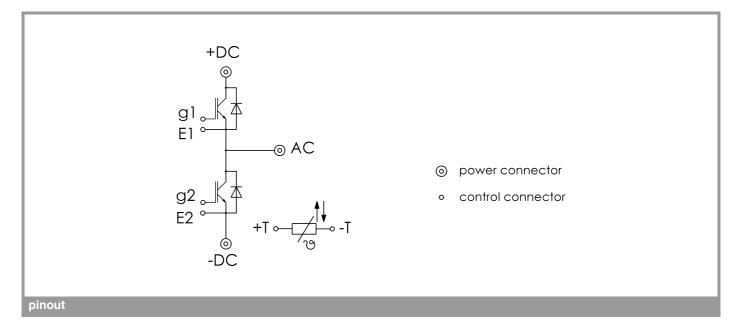




9000 [A/µs]



pinout, dimensions



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

***IMPORTANT INFORMATION AND WARNINGS**

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